SPECIFICATIONS

Customer	
Product Name	Wire Wound SMD Power Inductor
Sunlord Part Number	SPH252010H Series
Customer Part Number	

[New Released, Revised]

SPEC No.: SPH09160000

[This SPEC is total 14 pages.] [ROHS Compliant Parts]

Approved By	Checked By	Issued By

Shenzhen Sunlord Electronics Co., Ltd.

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[For Customer approval Only] Date: Qualification Status: Full Restricted Rejected			
Approved By	Verified By	Re-checked By	Checked By
mments:			

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[Version change history]

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	/	New released	/	Qintian Hou

Sunlord Categories: general confidential

1 Scope

This specification applies to the SPH252010H Series of wire wound SMD power inductor.

2 Product Description and Identification (Part Number)

1) Description:

SPH252010H series of Wire wound SMD power inductor.

2) Product Identification (Part Number)

1	Туре
SPH	Wire wound SMD power
320	inductor
3	Feature type

Н	High Type Material

5 Inductance Tolerance		
N ±30%		
M ±20%		
6	Packing	
T Tape Carrier Package		

	252010	2.5X2.0X 1.0			
г					
	④ N	Iominal Inductance			
	Example	Example			
	1R0	1.0uH			
Ī	2R2	2.2uH			
Ī	100	10uH			
-					
	⑦ Special Process code				
		Special Process code			
	* Standard product is blank				

External Dimensions(L×W×H) [mm]

3 Electrical Characteristics

Please refer to Item 12.

1) Operating and storage temperature range (individual chip without packing): -40 °C ~ +125 °C (Including Self-heating).

2

2) Storage temperature range (packaging conditions): -10 °C ~+40 °C and RH 70% (Max.)

4 Test and Measurement Procedures

5.1 Test Conditions

- 5.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:
 - a. Ambient Temperature: 20±15°C
 - b. Relative Humidity: 65±20%
 - c. Air Pressure: 86kPa to 106kPa
- 5.1.2 If any doubt on the results, measurements/tests should be made within the following limits:
 - a. Ambient Temperature: 20±2°C
 - b. Relative Humidity: 65±5%
 - c. Air Pressure: 86kPa to 106kPa

5.2 Visual Examination

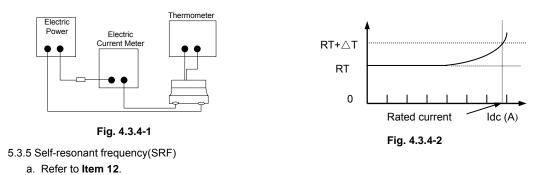
Inspection Equipment: 10X microscope

5.3 Electrical Test

- 5.3.1 Inductance (L)
 - a. Refer to Item 12. Test equipment: WK3260B LCR meter or equivalent.
 - b. Test Frequency and Voltage: refers to Item 6.
- 5.3.2 Direct Current Resistance (DCR)
 - a. Refer to Item 12.
 - b. Test equipment: HIOKI 3540 or equivalent.
- 5.3.3 Saturation Current (Isat)
 - a. Refer to Item 12.
 - b. Test equipment: WK3260B LCR meter or equivalent.
- 5.3.4 Temperature rise current (Irms)
 - a. Refer to Item 12.
 - b. Test equipment (see Fig. 4.3.4-1, Fig. 4.3.4-2): Electric Power, Electric current meter, Thermometer.
 - c. Measurement method
 - 1. Set test current to be 0 mA.
 - 2. Measure initial temperature of choke surface.
 - 3. Gradually increase current and measure choke temperature for corresponding current.
 - 4. Definition of Temperature rise current: DC current that causes the temperature rise (\triangle T) from ambient temperature

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b.Test equipment: Agilent E4991A+16197or equivalent



5 Shape and Dimensions

Dimensions and recommended PCB pattern for reflow soldering, please see Fig.5-1, Fig. 5-2 and Table 5-1.

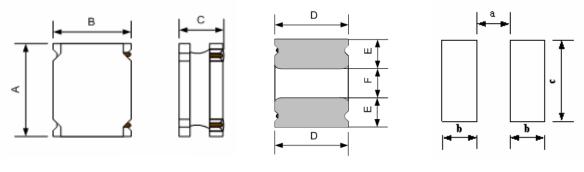
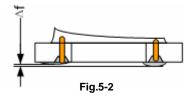


Fig.5-1,

[Table 5-1] (Unit: mm)

Series	А	В	C Max	D	E	F	а Тур.	b Typ.	с Тур.
SPH252010H	2.5±0.2	2.0±0.2	1.0	2.0±0.2	0.8±0.2	0.8±0.2	0.80	0.85	2.0



 Δf : Clearance between terminal and the surface of plate must be 0.1mm max when coil is placed on a flat plate.

6 Structure

The structure of SPH252010H product, please refer to Fig.6-1 and Table 6-1.

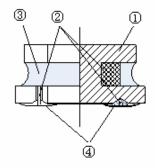


Fig. 6-1

7 Product Marking N/A

[Table 6-1]

No.	Components	Material
1	Ferrite Core	Ni-Zn Ferrite
2	Wire	Polyurethane system enameled copper wire
3	Magnetic Glue	Epoxy resin and magnetic powder
4	Electrodes	AgNiSn or FeNiCu + Sn Alloy

Reliability Test

8

Items	Requirements	Test Methods and Remarks
8.1 Terminal Strength	No removal or split of the termination or other defects shall occur. Y direct X direct Fig.8.1-1	 Solder the inductor to the testing jig (glass epoxy board shown in Fig.8.1-1) using eutectic solder. Then apply a force in the direction of the arrow. 10N force. Keep time: 5s
8.2 Resistance to Flexure	No visible mechanical damage.	 Solder the chip to the test jig (glass epoxy board) using eutectic solder. Then apply a force in the direction shown as Fig.8.2-1. Flexure: 2mm Pressurizing Speed: 0.5mm/sec Keep time: 30±1s Test board size: 100X40X1.0 Land dimension: Please see Fig. 5-1
8.3 Vibration	 No visible mechanical damage. Inductance change: Within ±10% 	 Solder the chip to the testing jig (glass epoxy board shown as the following figure) using eutectic solder. The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours).
8.4 Temperature coefficient	Inductance change: Within ±20%	 Temperature: -40°C~+125°C With a reference value of +20°C, change rate shall be calculated
8.5 Solderability	90% or more of electrode area shall be coated by new solder.	 The test samples shall be dipped in flux, and then immersed in molten solder. Solder temperature: 245±5°C Duration: 5±1 sec. Solder: Sn/3.0Ag/0.5Cu Flux: 25% resin and 75% ethanol in weight Immersion depth: all sides of mounting terminal shall be immersed
8.6 Resistance to Soldering Heat	 No visible mechanical damage. Inductance change: Within ±10% 	 Re-flowing Profile: Please refer to Fig. 8.6-1. Test board thickness: 1.0mm Test board material: glass epoxy resin The chip shall be stabilized at normal condition for 1~2 hours before measuring Peak 260°C max Peak 260°C max Max Ramp Up Rate=3°C/sec. Max Ramp Down Rate=6°C/sec. 60 90 sec. 150°C 50°C 120 sec. Time 25°C to Peak =8 min max Fig. 8.6-1

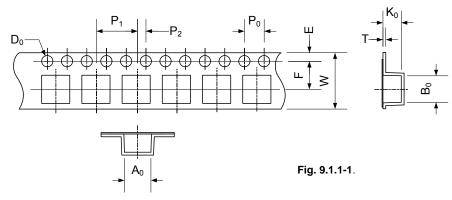
8.7 Thermal Shock	 No visible mechanical damage. Inductance change: Within ±10% 125°C 30 min. 30 min. Ambient	 Temperature and time: -40±3℃ for 30±3 min→125℃ for 30±3min, please refer to Fig. 8.7-1. Transforming interval: Max. 20 sec Tested cycle: 100 cycles The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.8 Resistance to Low Temperature	 No visible mechanical damage Inductance change: Within ±10% 	 Temperature: -40±3°C Duration: 1000^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.9 Resistance to High Temperature	 No mechanical damage. Inductance change: Within ±10% 	 Temperature: 125±2°C Duration: 1000^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring.
8.10 Damp Heat	 No mechanical damage. Inductance change: Within ±10% 	 Temperature: 60±2°C Humidity: 90% to 95%RH Duration: 1000^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.11 Loading Under Damp Heat	 No mechanical damage. Inductance change: Within ±10% 	 Temperature: 60±2°C Humidity: 90% to 95% RH Applied current: Rated current Duration:1000^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.12 Loading at High Temperature	 No mechanical damage. Inductance change: Within ±10% 	 Temperature: 85±2 ℃ Applied current: Rated current Duration: 1000^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring

9 Packaging, Storage

9.1 Tape and Reel Packaging Dimensions

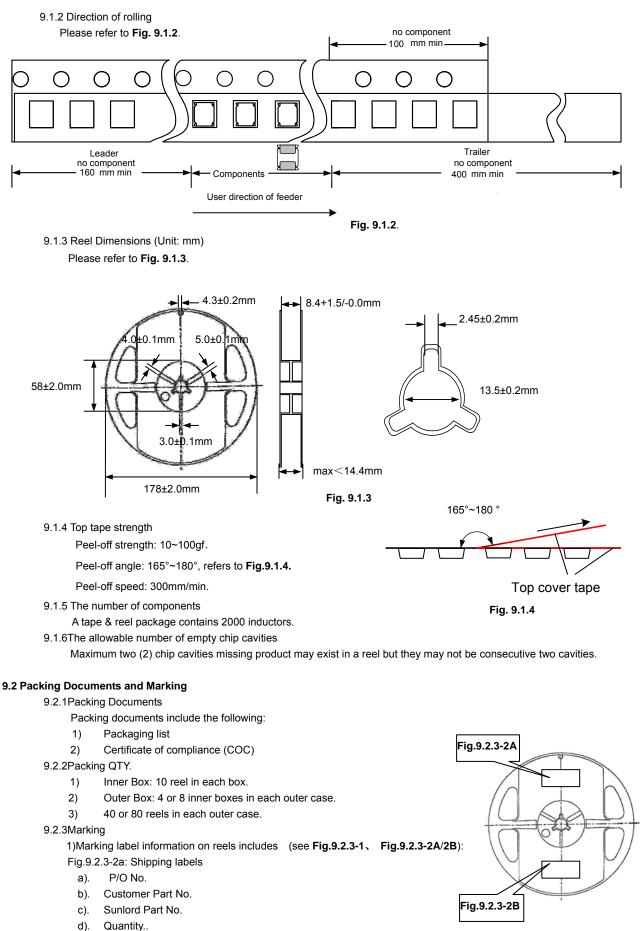
9.1.1Taping Dimensions (Unit: mm)

Please refer to Fig. 9.1.1-1 and Table 9.1.1-1.



[Table9.1.1-1]

Series	A ₀	B ₀	W	E	F	P ₀	P ₁	P ₂	D ₀	Т	K ₀
SPH252010H	2.45±0.05	2.75±0.05	8.0±0.1	1.75±0.1	3.5±0.05	4.0±0.1	4.0±0.1	2.0±0.05	1.5+0.1/-0.0	0.25±0.03	1.20±0.05



- e). Lot No.
- f). Date code
- g). Inspection stamp
- h). MFG address as 'Made In China'

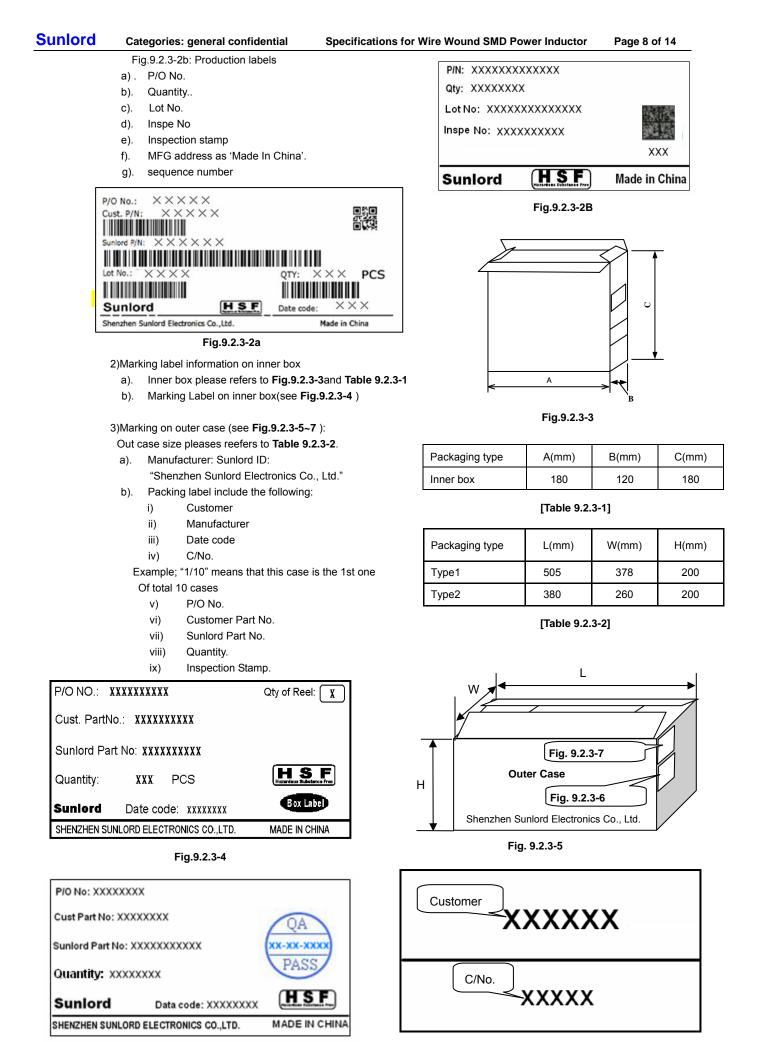


Fig.9.2.3-6

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10 .Vi	sual inspection s	tandard of product						
File No: Effective date:		Applied to Wire Wound SMD Power Inductor Series						
No.	Defect Item	Graphic	Rejection identification	Acceptance				
1	Core defect		The defect length/width (I or <i>w</i>) more than L/6 or W/6, NG.	AQL=0.65				
2	Core crack		Visual cracks, NG.	AQL=0.65				
3	Starvation		 Resin starved length, <i>I</i>, more than L/2, NG. ② IF <i>W</i>>2mm, resin starved width, <i>w</i>, more than W/2, NG. IF <i>W</i>≤2mm, resin starved width, <i>w</i>, don't control. 	AQL=0.65				
4	Excessive glue		The length, width or height of product beyond specified value, NG.	AQL=0.65				
5	Cold solder		Cold solders <i>I</i> more than 1 mm, NG.	AQL=0.65				
6	Solder icicle		 The height <i>H</i> of product beyond specified value, NG; The clearance Δ<i>f</i> beyond specified value listed in Item 5, NG; 	AQL=0.65				
7	Electrode uneven	Δf	The clearance Δf beyond specified value listed in Item 5 , NG;	AQL=0.65				

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11 Recommended Soldering Technologies

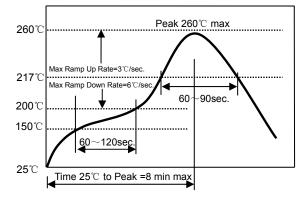
- 11.1Re-flowing Profile:
 - \triangle Preheat condition: 150 ~200 °C/60~120sec.
 - \triangle Allowed time above 217°C: 60~90sec.
 - △ Max temp: 260°C
 - \triangle Max time at max temp: 5sec.
 - \triangle Solder paste: Sn/3.0Ag/0.5Cu
 - \triangle Allowed Reflow time: 2x max
 - Please refer to Fig. 11.1-1.

[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

11.2 Iron Soldering Profile

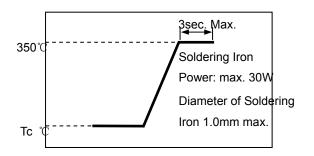
- \bigtriangleup $\,$ Iron soldering power: Max. 30W
- \triangle Pre-heating: 150°C/60sec.
- \bigtriangleup Soldering Tip temperature: 350 $^\circ\!\mathrm{C}$ Max.
- \triangle Soldering time: 3sec. Max.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- \triangle Max.1 times for iron soldering
- Please refer to Fig. 11.2-1.

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



Specifications for Wire Wound SMD Power Inductor







12 Electrical Characteristics Min. Saturation Heat Rating DC Resistance Customer Inductance Self-resonan Part Number Current Current P/N Marking @1MHz,1V t frequency Max. Тур. Max. Тур. Max. Тур. MHz Ω Ω Units μH А А А А L SRF DCR Isat Irms Symbol -SPH252010HR24MT 0.034 0.24±20% 360 0.028 3.60 4.40 2.75 3.00 N/A SPH252010HR33MT 0.33±20% 270 0.043 0.036 3.80 4.60 2.40 2.65 N/A N/A SPH252010HR47MT 0.47±20% 170 0.044 0.037 2.40 2.80 2.40 2.65 SPH252010HR68MT 0.68±20% 110 0.061 0.051 2.75 3.10 2.10 2.35 N/A SPH252010HR68MTY01 0.68±20% 110 0.061 0.051 2.75 3.10 2.10 2.35 N/A SPH252010HR68MTY02 0.68±20% 110 0.065 0.055 3.20 3.50 2.10 2.30 N/A SPH252010H1R0MT 1.0±20% 84 0.08 0.067 2.05 2.45 1.80 2.00 N/A 0.090 SPH252010H1R5MT 1.5±20% 60 0.108 1.70 2.05 1.55 1.70 N/A SPH252010H2R2MT 2.2±20% 56 0.137 0.114 1.55 1.80 1.40 1.55 N/A 39 0.228 0.170 N/A SPH252010H3R3MT 3.3±20% 1.10 1.40 1.10 1.20 SPH252010H4R7MT 4.7±20% 28 0.323 0.269 1.00 1.15 0.91 1.00 N/A SPH252010H6R8MT 6.8±20% 25 0.451 0.376 0.82 0.95 0.76 0.84 N/A SPH252010H100MT 10±20% 20 0.584 0.487 0.65 0.75 0.67 0.74 N/A 0.795 SPH252010H150MT 15±20% 19 0.954 0.55 0.65 0.50 0.55 N/A 0.55 SPH252010H220MT 22±20% 15 1.548 1.290 0.40 0.45 N/A 0 45 SPH252010H330MT 33±20% 10 1.548 1.290 0.25 0.30 0.40 0.45 N/A

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Note: %1 : Rated current: Isat or Irms, whichever is smaller;

%2: Saturation Current: Max. Value, DC current at which the inductance drops less than 30% from its value without current; Typ. Value, DC current at which the inductance drops approximate 30% from its value without current;

%3: Irms: DC current that causes the temperature rise (ΔT) from 25°C ambient temperature.

For Max. Value, $\Delta T < 40^{\circ}$ C; for Typ. Value, ΔT is approximate 40° C.

The part temperature (ambient + temp. rise) should not exceed 125 °C under worst case operating conditions. Circuit design, component placement, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.

Please refer to appendix

13 Precautions

13.1 Surface mounting

- Mounting and soldering condition should be checked beforehand.
- Applicable soldering process to this product is reflow soldering only.
- Recommended conditions for repair by soldering iron:
 - Preheat the circuit board with product to repair at 150°C for about 1 minute.
 - Put soldering iron on the land-pattern.

Soldering iron's temperature: 350 °C maximum/Duration: 3 seconds maximum/1 time for each terminal.

The soldering iron should not directly touch the inductor.

Product once removes from the circuit board may not be used again.

13.2 Handing

- Keep the products away from all magnets and magnetic objects.
- Be careful not to subject the products to excessive mechanical shocks.
- Please avoid applying impact to the products after mounted on pc board.
- Avoid ultrasonic cleaning.

13.3 Storage

• To maintain the solderability of terminal electrodes and to keep the packing material in good condition, temperature and humidity in the storage area should be controlled.

- Recommended conditions: -10°C~40°C, 70%RH (Max.)
- Even under ideal storage conditions, solderability of products electrodes may decrease as time passes. For this reason, product should be used with one year from the time of delivery.
- In case of storage over 6 months, solderability shall be checked before actual usage.

13.4 Regarding Regulations

- Any Class- I or Class- II ozone-depleting substance (ODS) listed in the Clean Air Act in US for regulation is not included in the products or applied to the products at any stage of whose manufacturing processes.
- Certain brominated flame retardants (PBBs, PBDEs) are not used at all.
- The products of this specification are not subject to the Export Trade Control Order in China or the Export Administration Regulations in US.

13.5 Guarantee

- The guaranteed operating conditions of the products are in accordance with the conditions specified in this specification.
- Please note that Sunlord takes no responsibility for any failure and/or abnormality which is caused by use under other than the aforesaid operating conditions.

14 Supplier Information

14.1 Supplier:

Shenzhen Sunlord Electronics Co., Ltd.

14.2 Manufacturer:

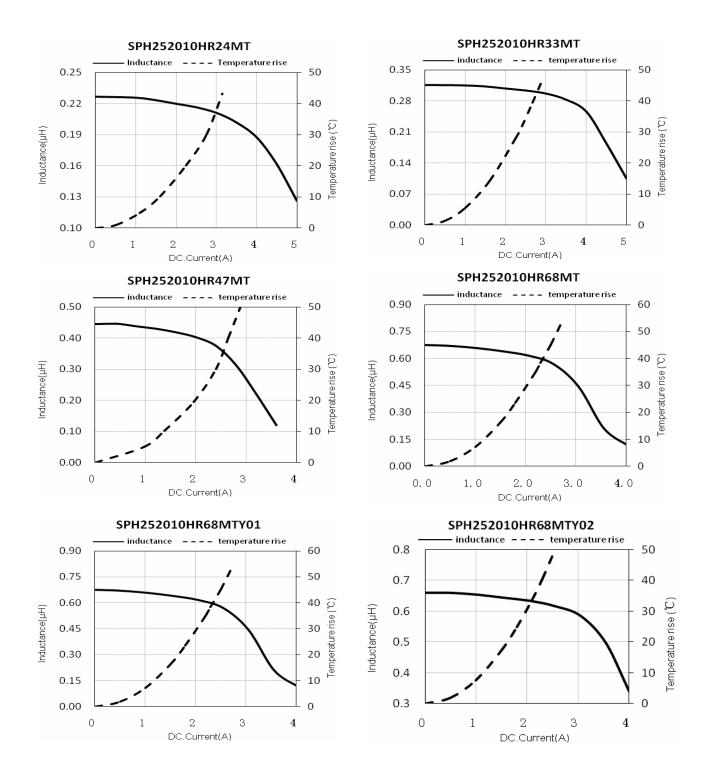
Shenzhen Sunlord Electronics Co., Ltd.

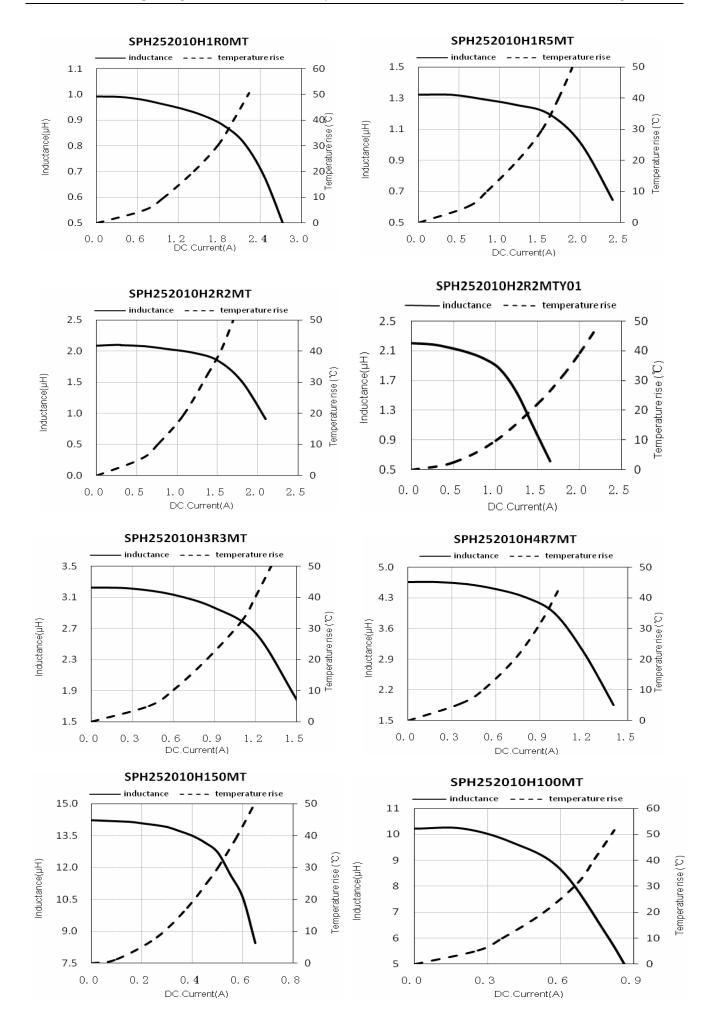
14.3 Manufacturing Address:

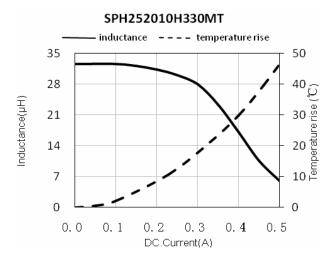
Sunlord Industrial Park, Dafuyuan Industrial Zone, Guanlan, Shenzhen, China Zip: 518110

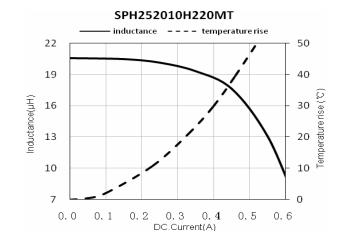
Appendix

Typical Electrical Characteristics









X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for sunlord manufacturer:

Other Similar products are found below :

TC212B476K010YMWSA1205S-R82MTTC212B476M010BSWRH6D38S-100MTSDWL3225CR10JSTFTC211B476K010AMWSA1004S-R36MTSWRH1207B-820MTTC212B476M010YASWPA6055S101MTSDWL3216C15NJSTFSDWL3216CR47JSTFSDCW3225S-2-161TFASWPA6055S3R3MTSPH4018HR33NTMWSA1204S-R82MTSDCW1210S-2-350TFSDCW1210S-2-161TFMWSA0503S-1R5MTSPH8030H330MTSDCW2520S-2-451TFMWSA0402S-220MTMWSA0603-8R2MTASWPA8050S150MTSWPA6020S1R0NTWPN252010UR24MTSWPA5040S1R8MTSDCW2012H-2-900TFMPL2520S1R5MHTWPN252010H1R0MTY02WPN252010HR33MTY03WPN4012HR68MTSPH201610UR47MTY01SDWL1005C4N3SSTFM01SDWL1005C82NJSTFM01SDWL1608C43NJSTFM01MWSA0624S-1R0MTSDWL1005C43NJSTFM01SDCW2012C-2-181TFMWSA1204S-R68MTR22MTSDWL2520FW100JSTFSPH8030H3R3MTTC211A336K010YSPH3012H3R3MTSDCW1608S-2-141TFASWPA8050S100MTMWSA0624S-R56MTASWPA4035S1R2MTPZ3216U600-3R0TFSDCW16008S-2-141TFASWPA8050S100MT